



Certificate of Presentation

We certified that the work entitled $1.06 \mu\text{m}$ emission analysis in Nd^{3+} doped oxyfluoro tellurite glass and glass ceramic containing NaYF_4 nanocrystals, by RAJESH, D.; AMJAD, R. J.; CAMARGO, A. S. S. was presented as a Poster at the XVIII BMIC - Brazilian Meeting on Inorganic Chemistry and 7th Brazilian Meeting on Rare Earths, held at Hotel Colina Verde, São Pedro – SP, Brazil, from September, 25-30th, 2016.

Sidney J.L. Ribeiro
(Chair)

